

2019/ July 10 – July 12
Cygnus work shop

Analysis Chain for NEWSdm Experiment

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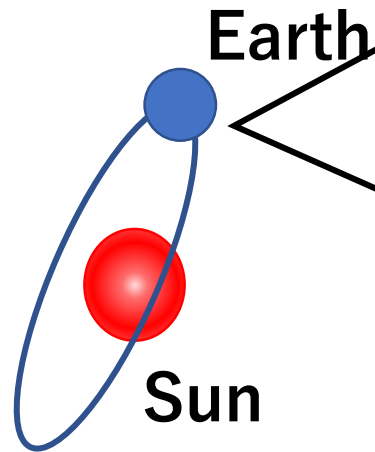
On behalf of the NEWSdm Collaboration

NEWSdm experiment

Cygnus



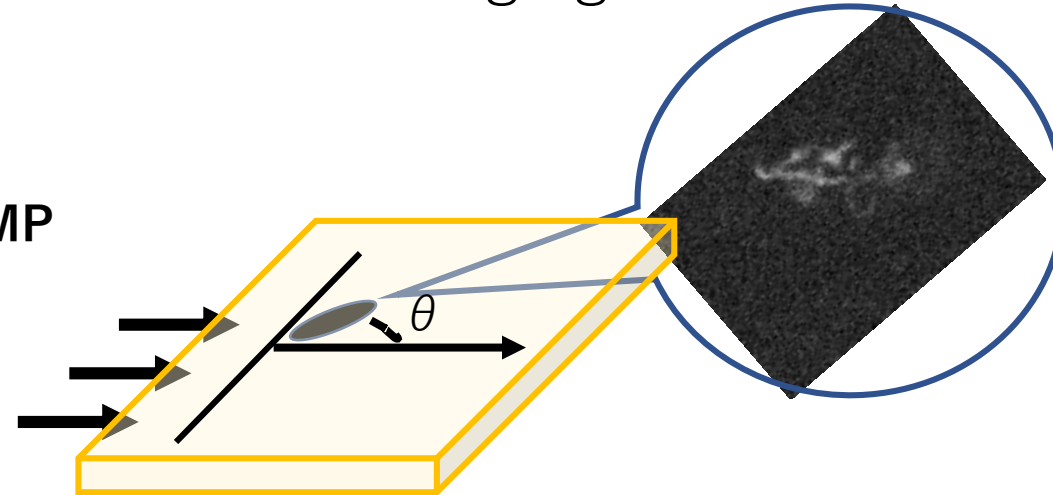
240 km/s



Detector

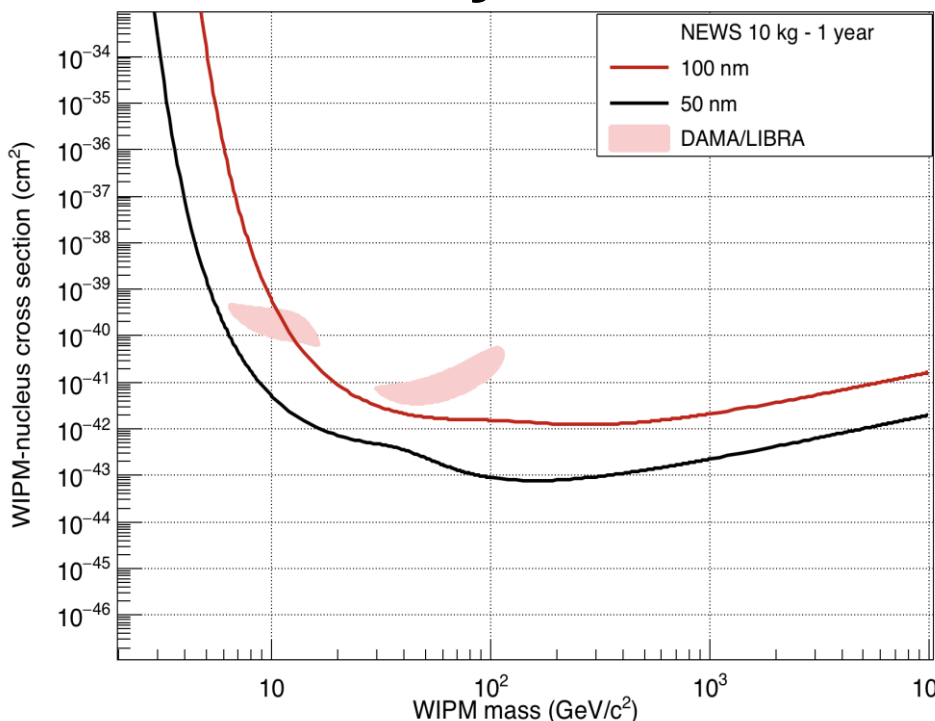
NIT : Nano Imaging Tracker

WIMP



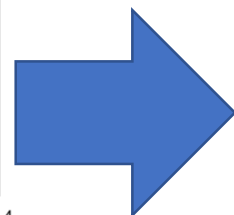
Get direction of WIMP

Sensitivity curve



assumption

- Exposure : 10 kg · year
- 0 background event



To search DAMA region

-> Need to 10 kg · year exposure at least

Feature of NIT

1. High mass density

2. nanometric spatial resolution

3. Analyze Tracks by various methods

Feature1 : High mass density

NIT : **N**ano **I**maging **T**racker
(Super fined grained nuclear emulsion)



T.Asada et al, PTEP, 063H01, (2017)

Mass density : 3.44 g/cm^3

+

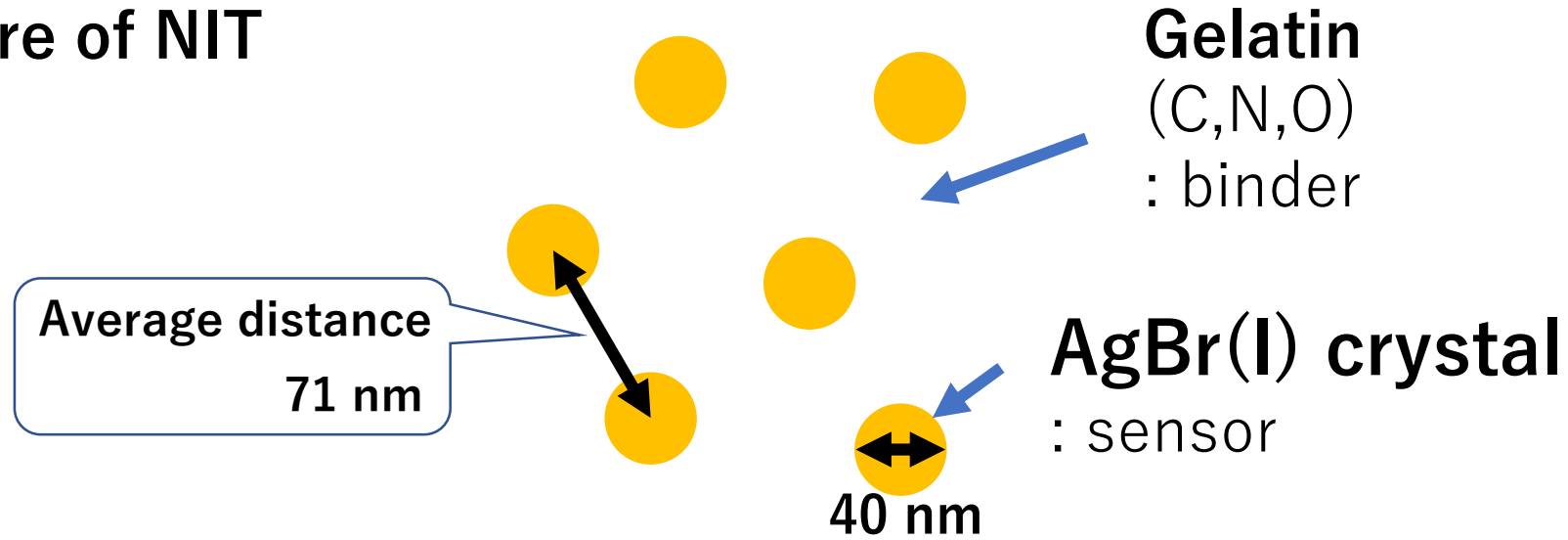
Production time : 1 month /10 kg NIT



NIT has high scalability

Feature2 : High spatial resolution

Structure of NIT

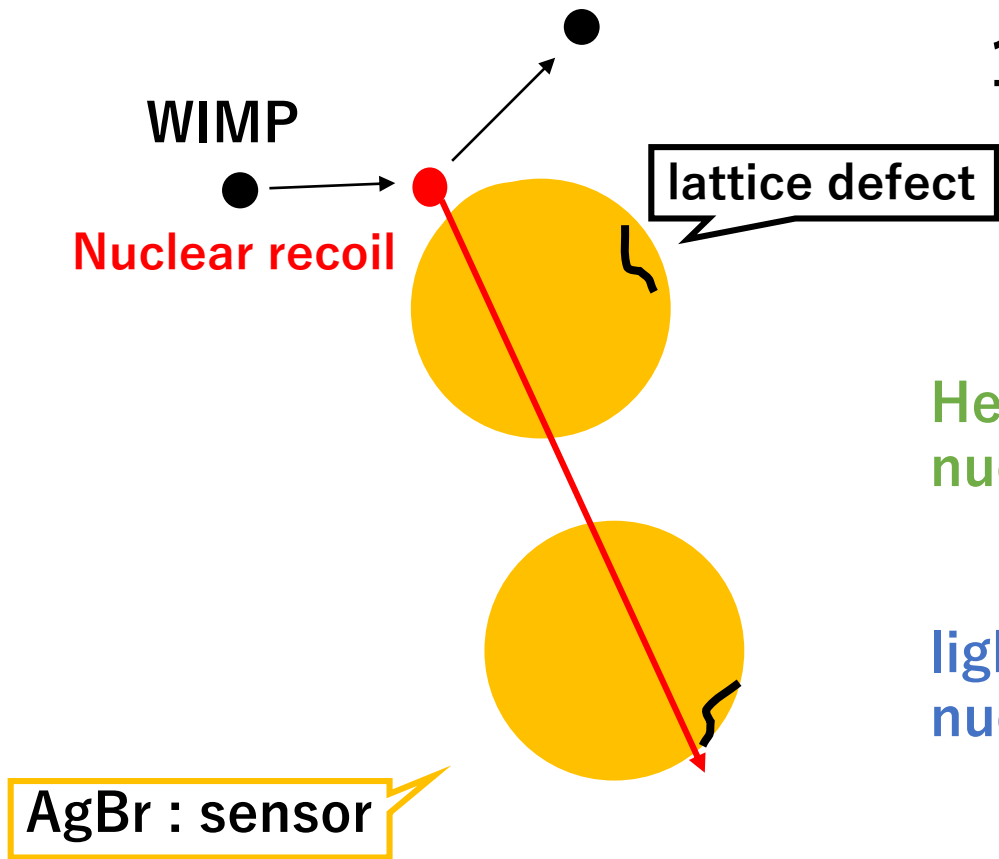


- **small sensor size**
(40 nm)
- **high numerical density**
($O(10^4) / \mu\text{m}^3$)

Make high spatial resolution

NIT can record direction of **more than 71 nm track intrinsic**

Track generation in NIT



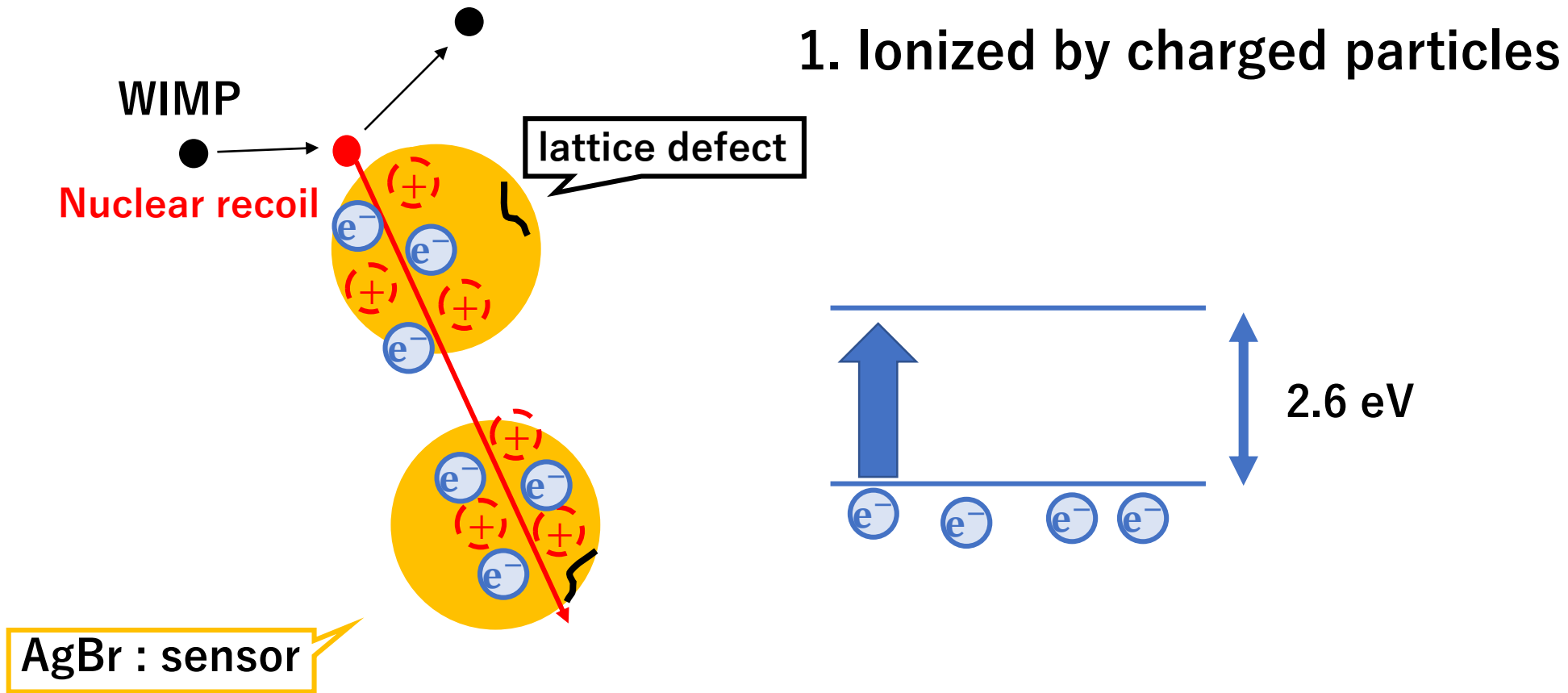
1. Ionized by charged particles

Components of NIT

	Element	Mass%	Atom%
Heavy nucleus	Ag	44.5	10.5
	Br	31.8	10.1
	I	1.9	0.4
light nucleus	C	10.1	21.4
	N	2.7	4.9
	O	7.4	11.7
	H	1.6	41.1

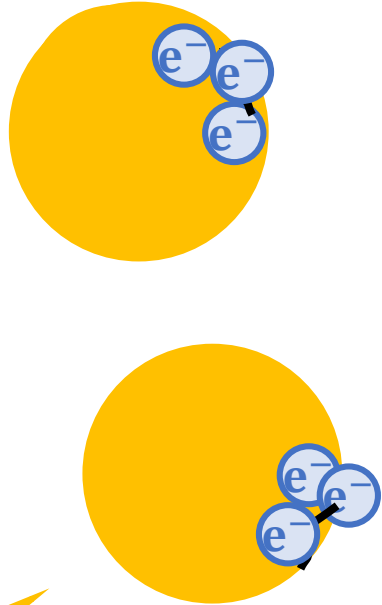
T.Asada et al, PTEP, 063H01, (2017)

Track generation in NIT



Track generation in NIT

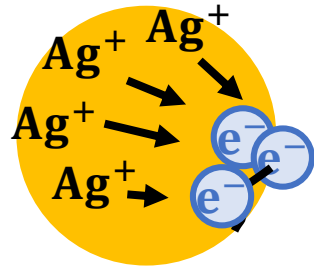
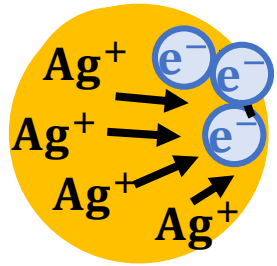
1. Ionized by charged particles
2. Electrons are trapped in lattice defect



AgBr : sensor

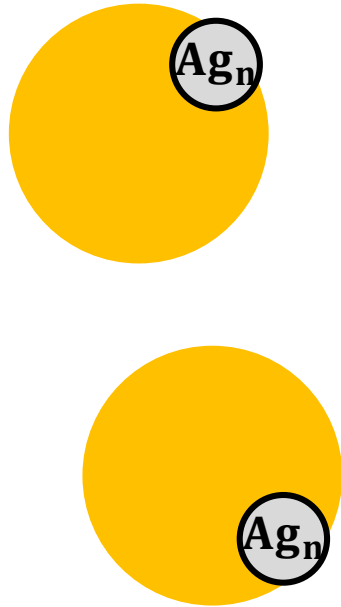
Track generation in NIT

1. Ionized by charged particles
2. Electrons are trapped in lattice defect
3. Ag^+ gather to lattice defect and produce latent images

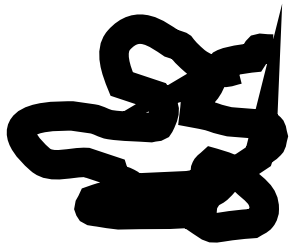


Track generation in NIT

1. Ionized by charged particles
2. Electrons are trapped in lattice defect
3. Ag^+ gather to lattice defect and produce latent images



Track generation in NIT



silver filament

1. Ionized by charged particles
2. Electrons are trapped in lattice defect
3. Ag^+ gather to lattice defect and produce latent images
4. Chemical development
amplitude Ag size
to be possible to observe in microscope

But ...

Cannot analyze without readout

NIT + scanning system -> work as detector

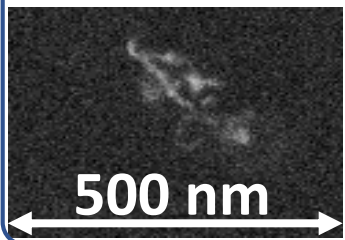
How can we readout nano scale information?

Readout requirement

- fast readout
- get nanoscale information as detailed as possible

Which microscope system should we use for getting nano scale information?

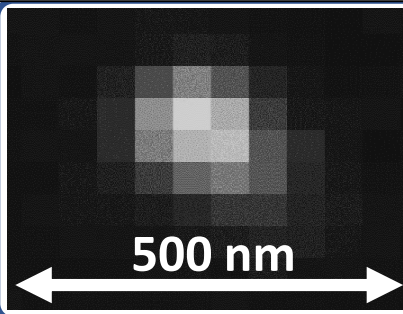
Electron microscope (SEM)



- **Have high resolution** (less than $0(1)\text{nm}$)
- **Takes too long time to scan full volume of NIT.** ($\sim 0(10^5)$ year/ 10kgNIT)

-> not realistic to scan by SEM

Optical microscope



- **Need short time for readout**
- **Resolution is limited by Rayleigh's limit** (more than 200 nm)

Aim to readout nm scale track information beyond Rayleigh's limit by optical microscope

Nano scale information tracking system

Readout system : PTS (Post Track Selector)

PTS2



PTS3



**Objective lens : Magnification 100x
N.A 1.45**

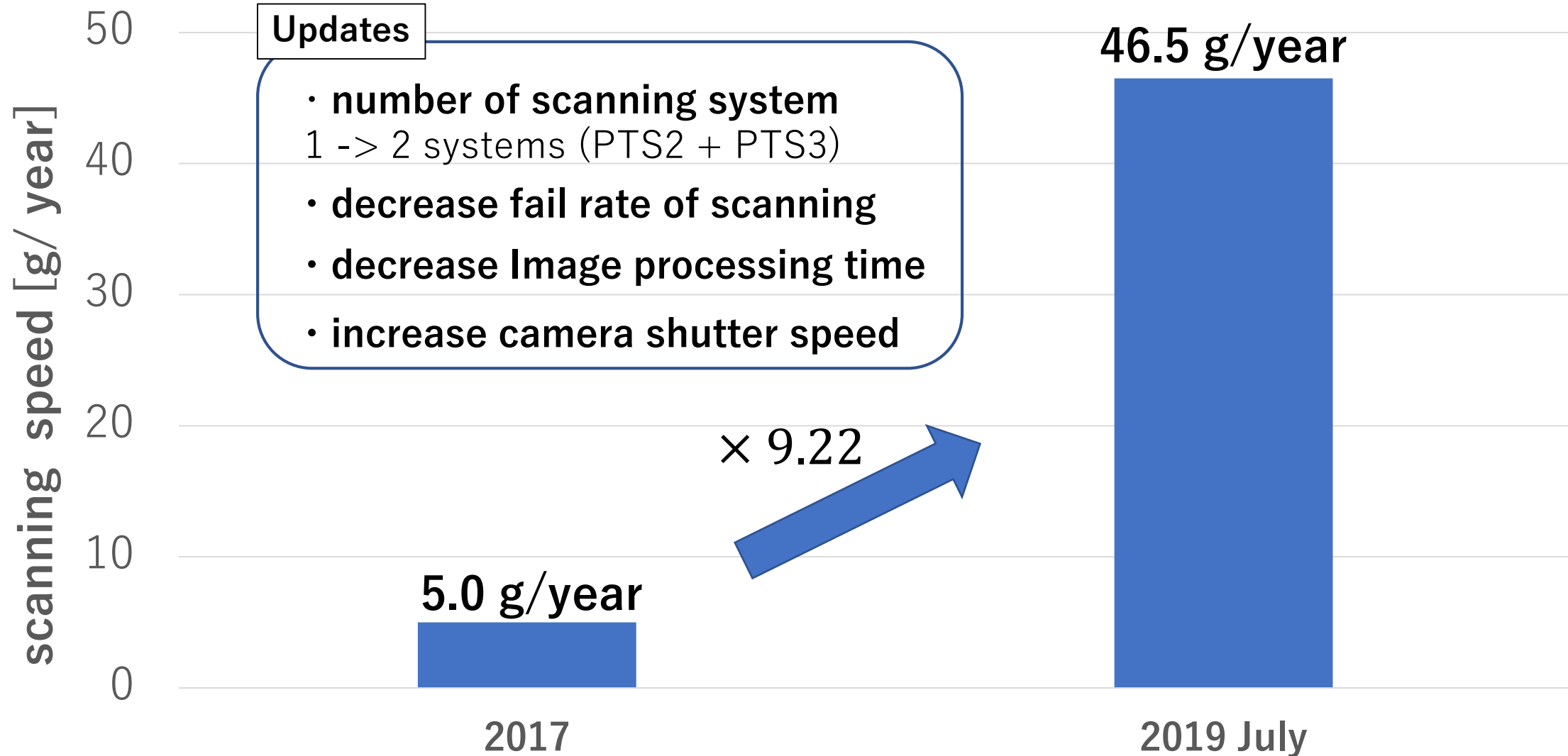
**CMOS camera : 4M pixel, 160 fps (PTS2)
2M pixel , 300 fps(PTS3)
55 nm / pix**

Light source : LED lamp w/ $\lambda \sim 460$ nm

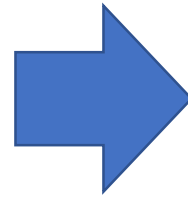
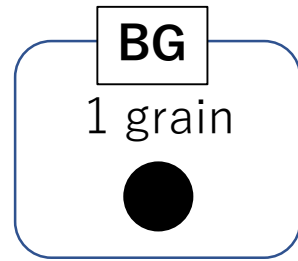
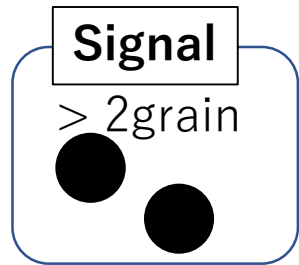
Spatial resolution : ~ 230 nm

Scanning speed

Scanning speed of ellipse analysis

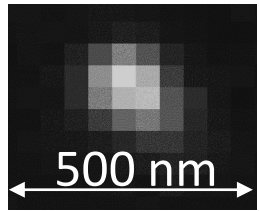


Readout nanoscale information: shape analysis

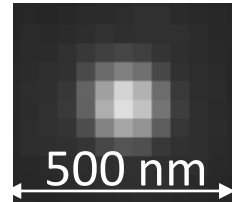


Distinguish by event shape

Ellipse analysis

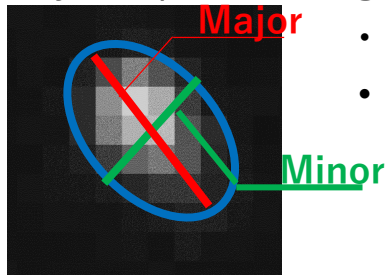


C ion Tracks



Ag nano particle

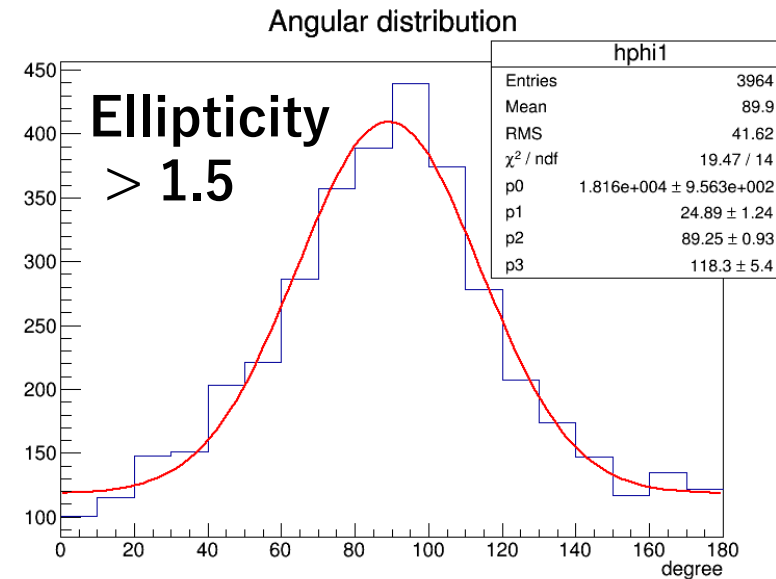
Get information of track
by ellipse fitting



- **major angle** <- track direction
- **ellipticity** = major / minor <- related to track length

T. Katsuragawa et al., JINST, 12, 04, T04002 (2017).

60 keV C ion Angle distribution

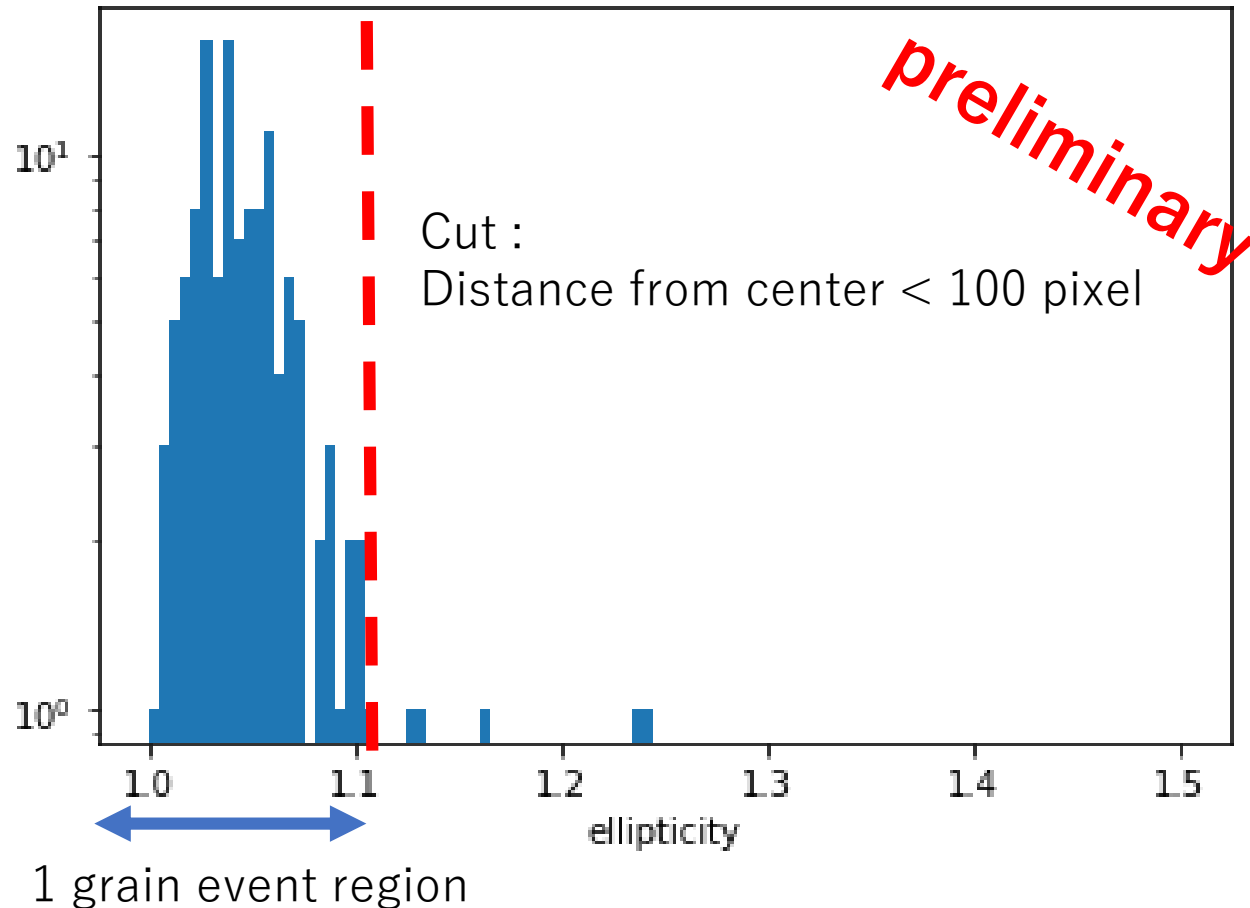


Detect angle information
of nano scale tracks

Setting the threshold to maximize efficiency: look at background distribution

Measured ellipticity distribution of 1grain events (Ag nano particle)

40nm Ag nano particle ellipticity distribution



1.1 < ellipticity
Can use for signal region

Existing events in NIT

Events existing in NIT

Non physical events

Dust : $O(10^{10}) / \text{kg}$

Contamination during production

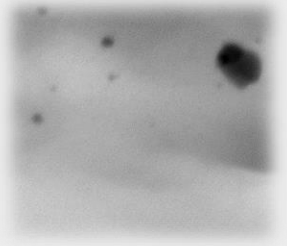
not Silver

not filament

Fog

Noise induced by developing

sphere Silver



- element
- shape

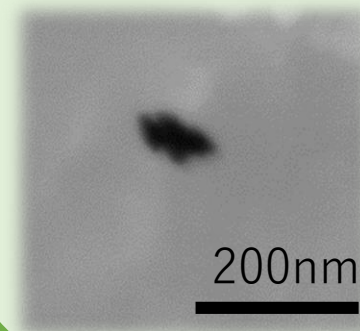
- shape

Physical events

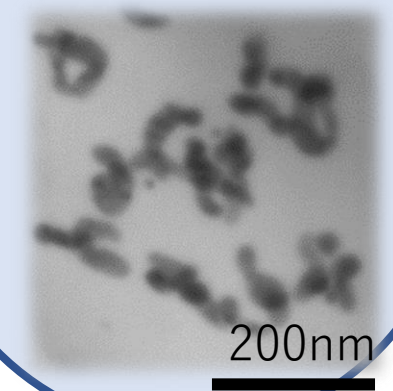
Silver with filament

Intrinsic BG event
 $O(10^8) / \text{kg} \cdot \text{year}$

Electron event



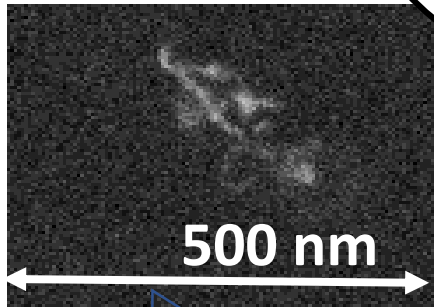
Nuclear Recoil event



Difficult to distinguish events by elliptical fitting -> how to?

Feature 3 Analyze track by various methods

Real track information

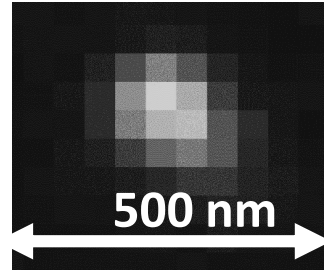


Difficult to read out

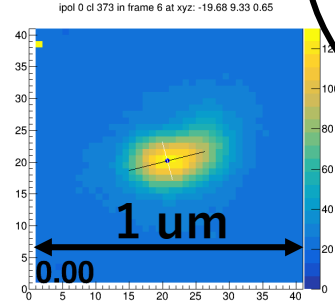
Be kept semi permanently

→ possible to analyze by various methods

Epi-illumination

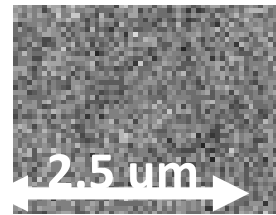


polarization

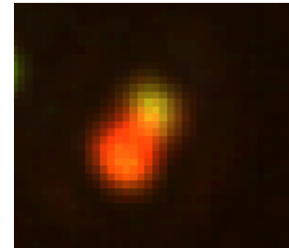


Observable information

Phase contrast



color



+

Machine learning

get real track information

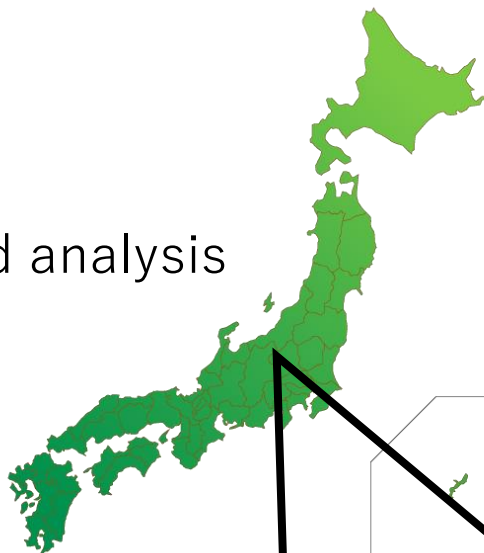
- BG rejection
- Super-resolution analysis

Scanning system for NIT

There are 5 scanning systems for NIT

Japan

- High speed analysis



Nagoya

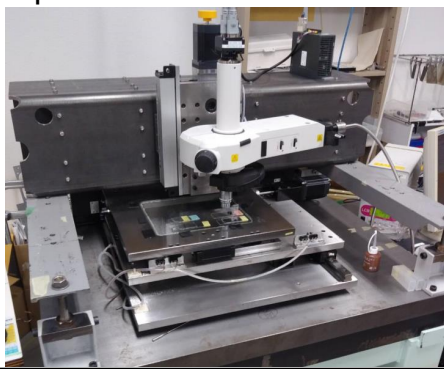
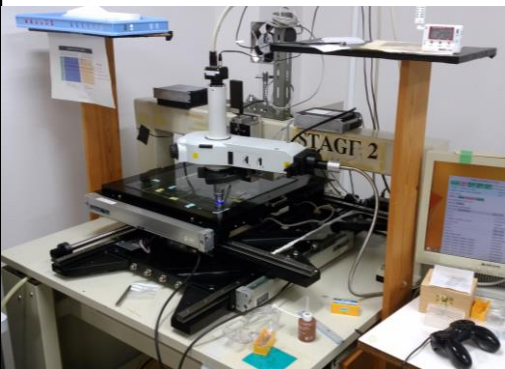
PTS : Post Track Selector

PTS2

- ellipse fitting

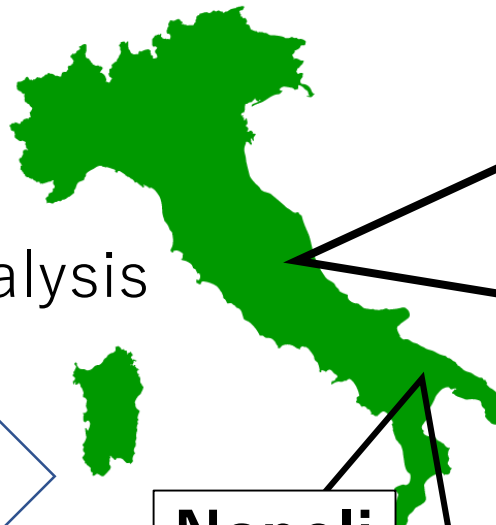
PTS3

- ellipse fitting
- phase contrast



Italia

Detail analysis



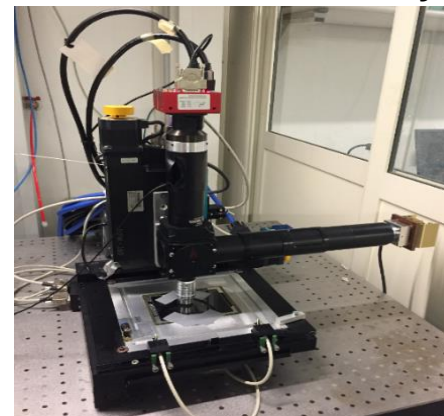
Send samples

Napoli

NSS : Napoli Scanning System

NSSna1 – polarization analysis

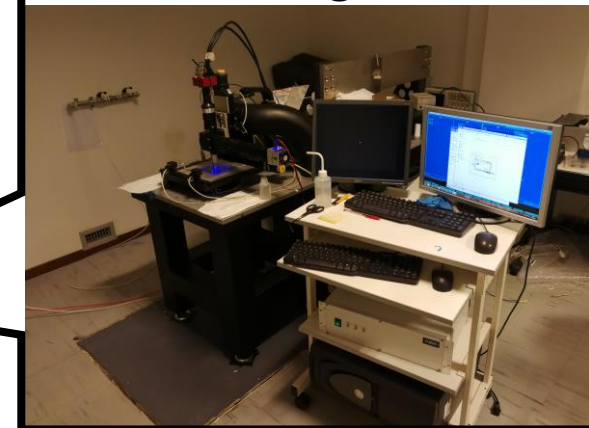
NSSna2 – color analysis



LNGS

NSSGs1

– constructing now

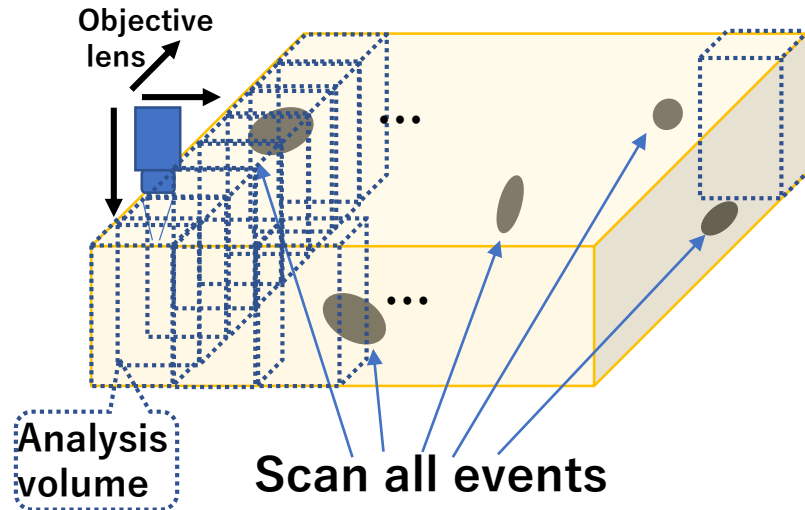


Analysis concept in NEWSdm experiment

Full Volume scanning

High speed and rough event selection

Search full volume NIT for tracks

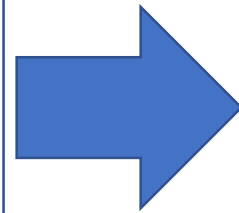


Analysis time is almost occupied by this scanning
-> **limit experiment scale.**

Analysis technique

- **Ellipse analysis**

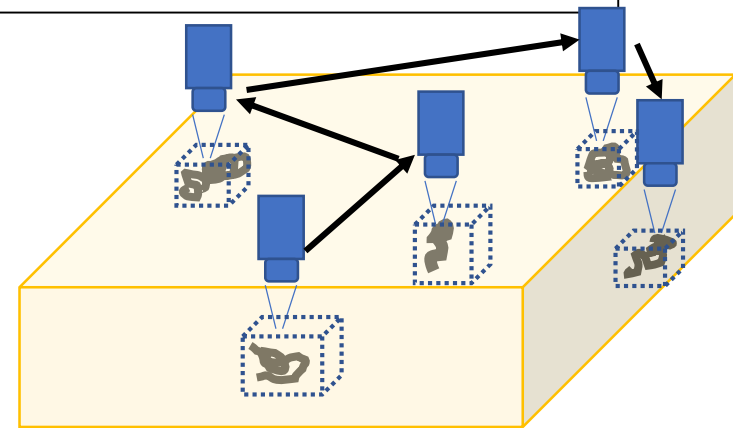
Selected candidates



Detail Event analysis (Point scanning)

Reconstruct nanoscale information

Analysis only candidate events



- **Get various detail information**
- length, direction, element etc.
- **reject BG events**

Analysis technique

- **Polarization analysis**
- **Multi wave length analysis**
- **phase contrast**

} Under developing **20**

Detail event analysis : Phase contrast analysis

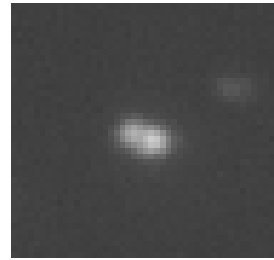
Concept : event selection by its nature (silver/dust) and shape

What is dust event

Event comes during NIT production
<- not made by physics event

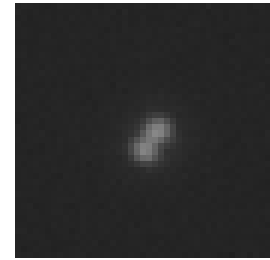
→ impossible to separate these events
by epi-illumination optics

100 keV C ion



2.7 μm

Dust events



2.7 μm

Features of event

	Track	Dust
element	silver	Not silver (metal oxide?)
shape	filament	Not filament



How to distinguish ?

Phase contrast analysis

How to distinguish ?

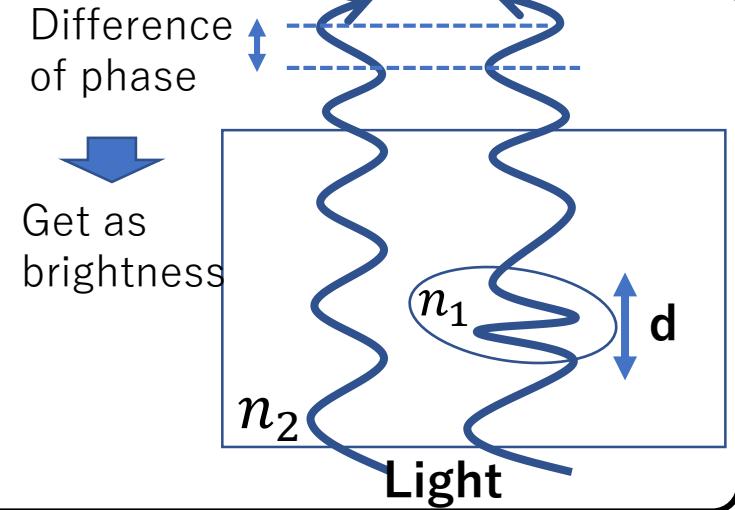
use **phase information**

- refractive index
- shape

Get phase information as brightness by phase contrast microscope

Difference of optical path
 $(n_2 - n_1)d$
-> this make difference of phase

n_i : refractive index
 d : event size



Phase contrast analysis

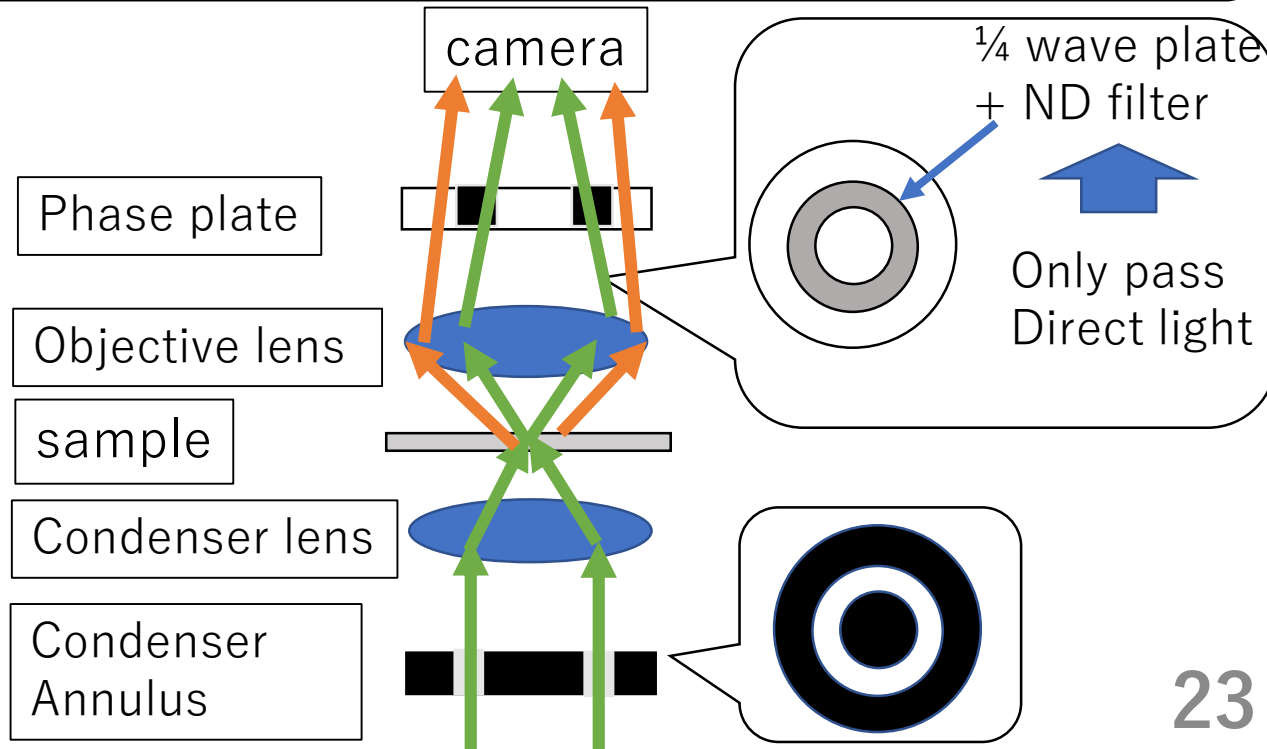
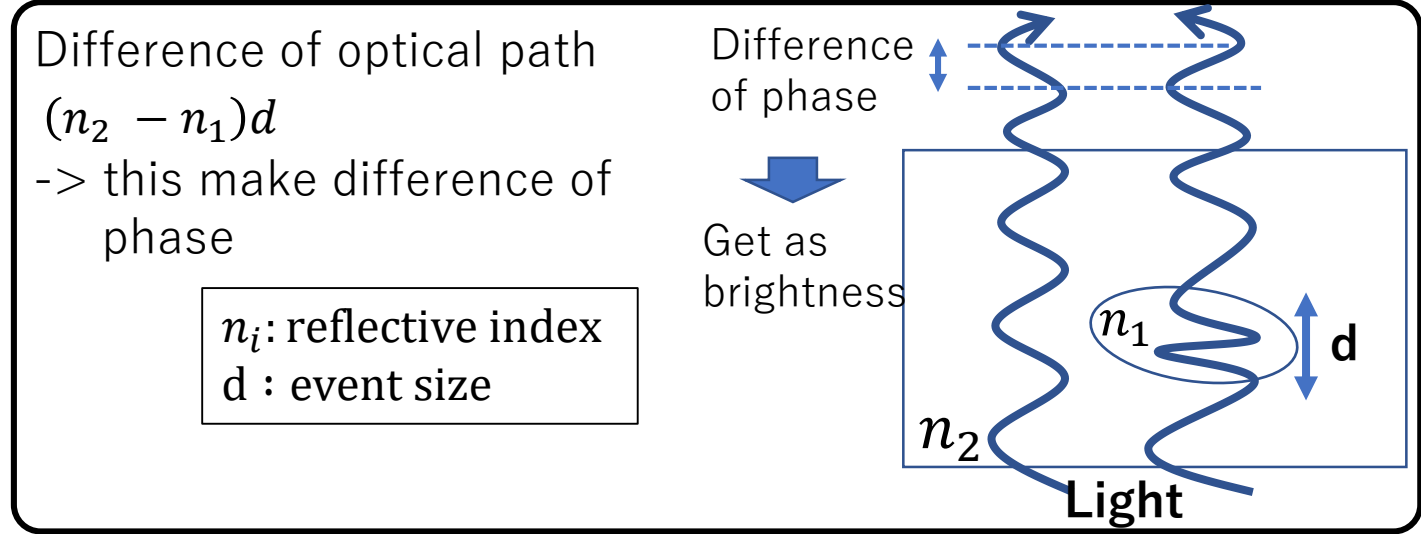
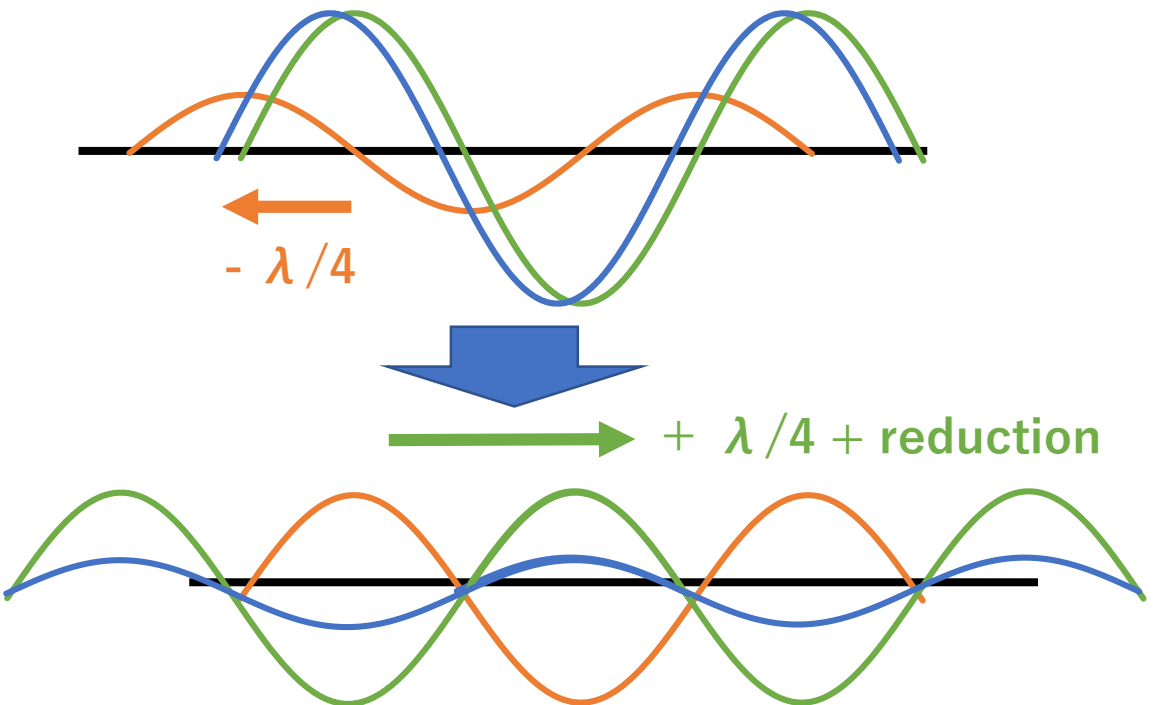
How to distinguish ?

use **phase information**

- refractive index
- shape

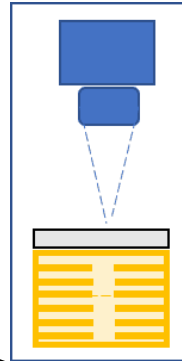
Get phase information as brightness by phase contrast microscope

Imaging light
= **Direct light** + **Diffracted light**



Phase contrast analysis

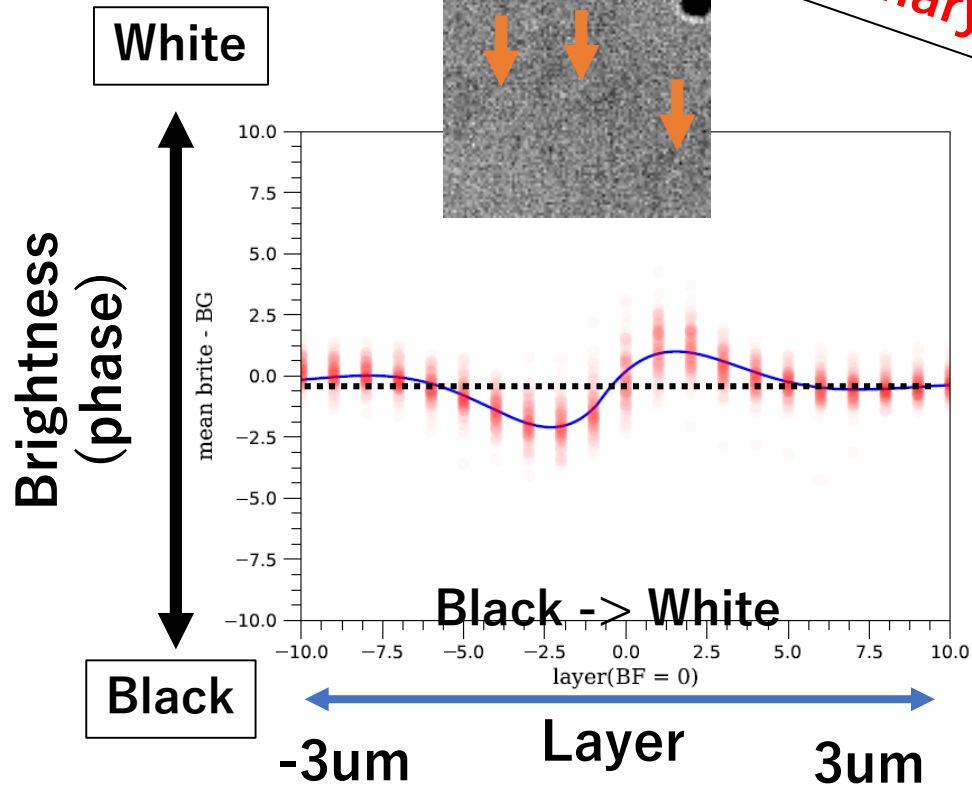
Take tomographic images of phase contrast



Observe phase (color) change by changing layer.

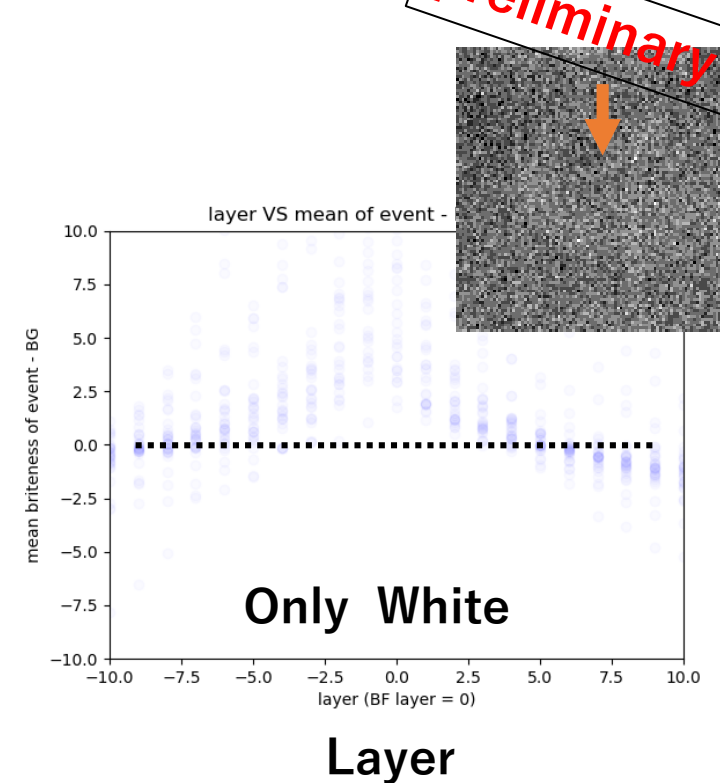
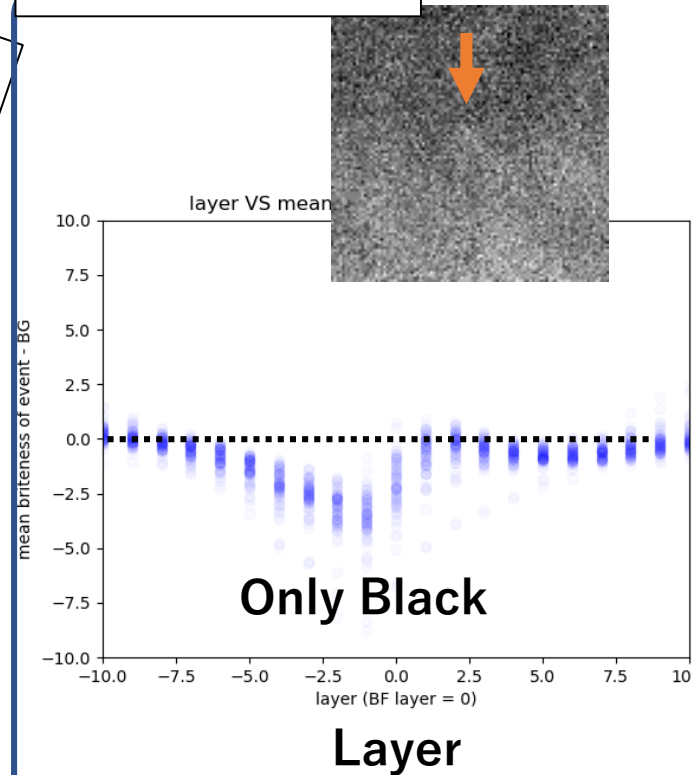
100 keV C ion

preliminary



dust events

preliminary



LSPR : Localized Surface Plasmon Resonance

Detail analysis technique

- phase contrast
- Multi wave length analysis
- Polarization analysis

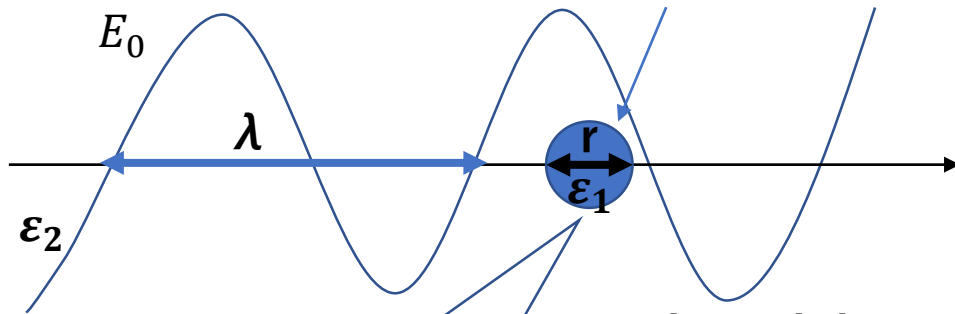


Use **LSPR** : Localized Surface Plasmon Resonance

What is LSPR ?

If $R < \lambda$

Unique to metal nanoparticles
metal nanoparticle



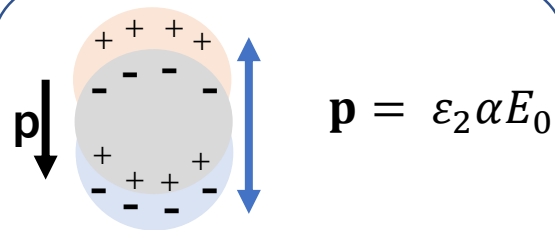
polarizability

$$\alpha = 4\pi r_1^3 \frac{\epsilon_1(\omega) - \epsilon_2}{\epsilon_1(\omega) + 2\epsilon_2}$$

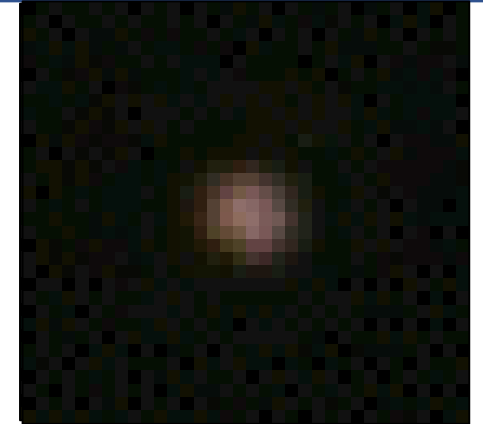
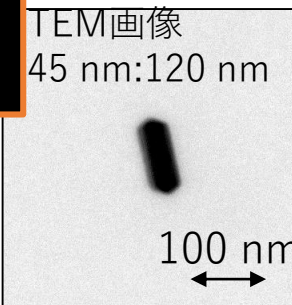
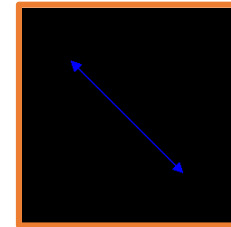
Resonance condition

$$\text{Re}(\epsilon_1(\omega) + 2\epsilon_2) \sim 0$$

decide by $\left\{ \begin{array}{l} \cdot \text{wavelength} \\ \cdot \text{shape, size} \end{array} \right.$

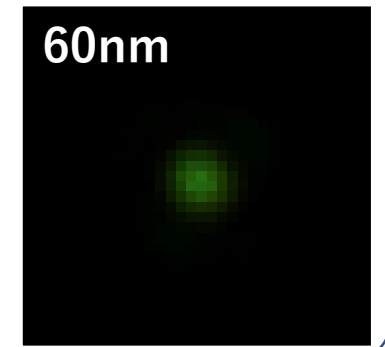
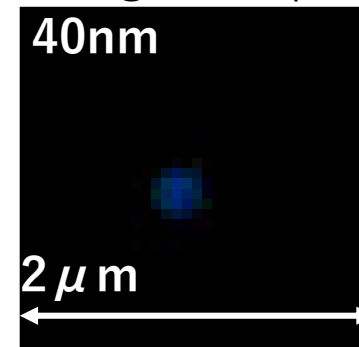


Free electron vibration
Caused by light



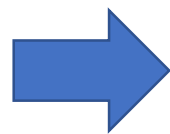
Size effect of event's color

Ex) Ag Nano particle



Multi wave length and Machine learning analysis

Concept : get shape information less than optical resolution



Use color information caused by LSPR

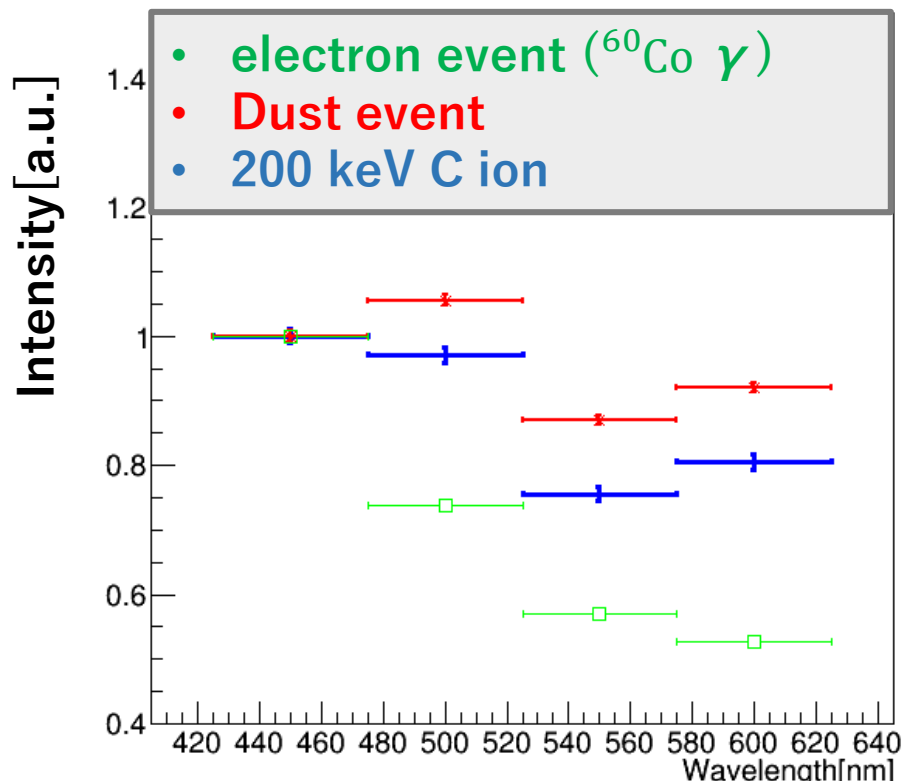
Reject { dust, electron } event

Color spectra is different event by event
-> show each event has different shape

BG rejection

Multi wave length analysis

C200keV vs Dust



Multi variable Analyze by machine learning

Give parameter

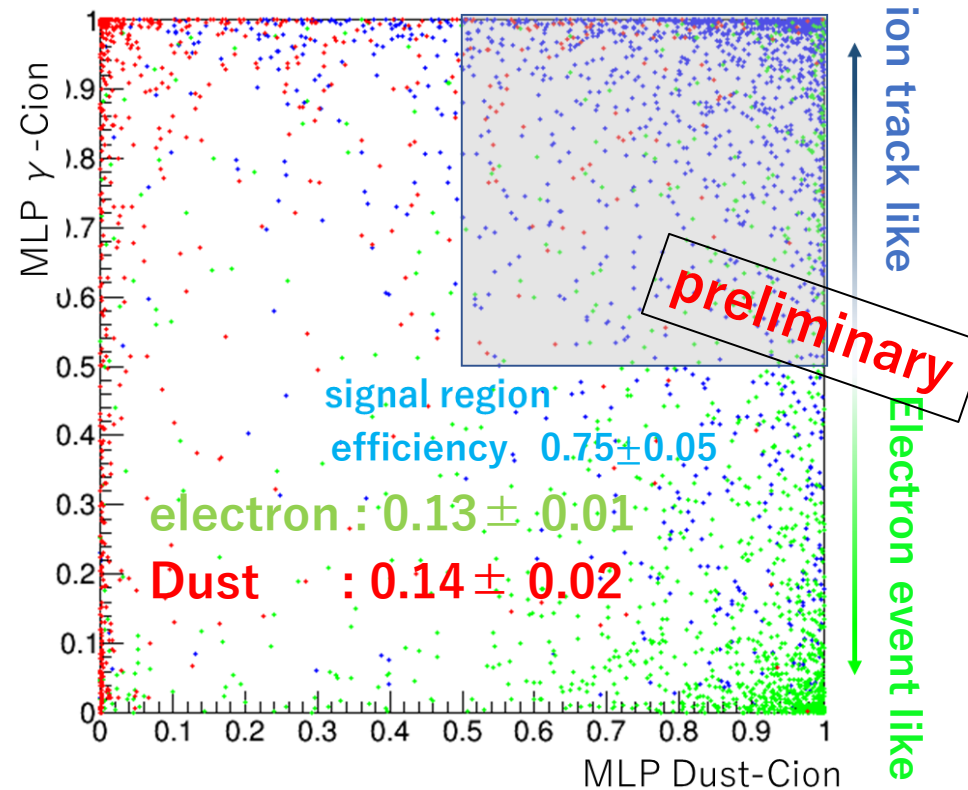
- brightness
- size

In each wavelength



Dust event like

C ion track like

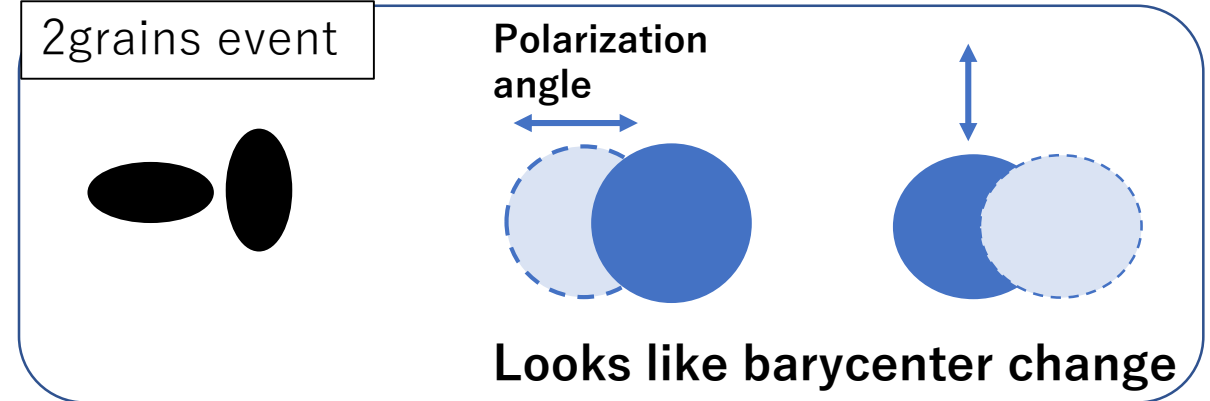
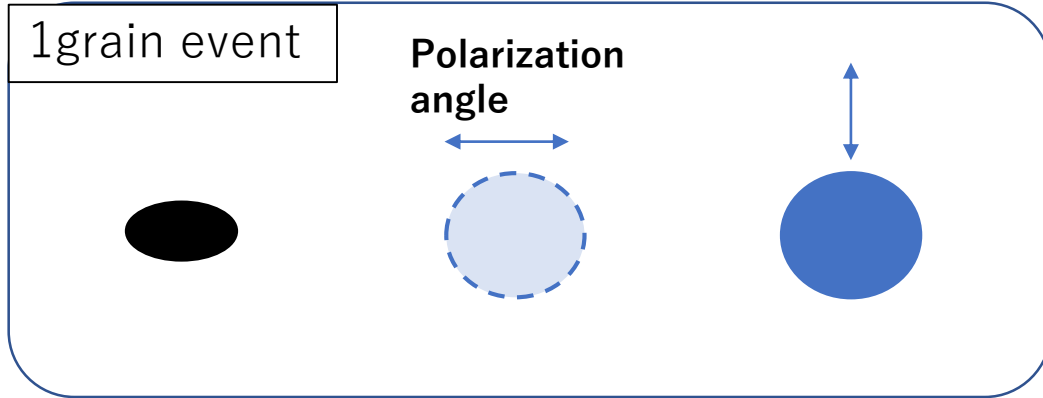


Polarization scanning

Concept : **Super resolution analysis**

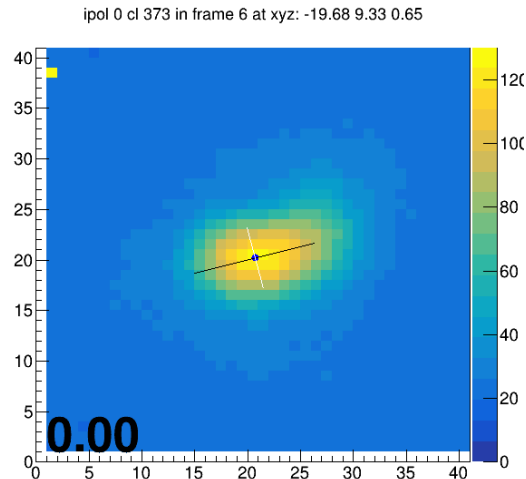
by using polarization information of optical image

Select events consist of more than 2 grains

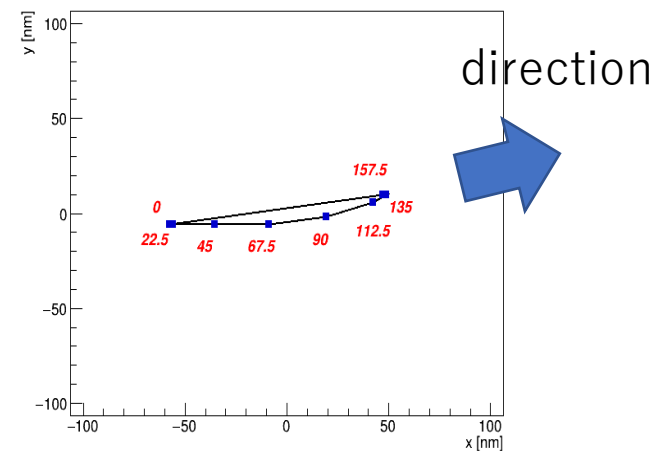


Method

Barycenter of event is changed by polarization angle



Barycenter position of each polarization angle

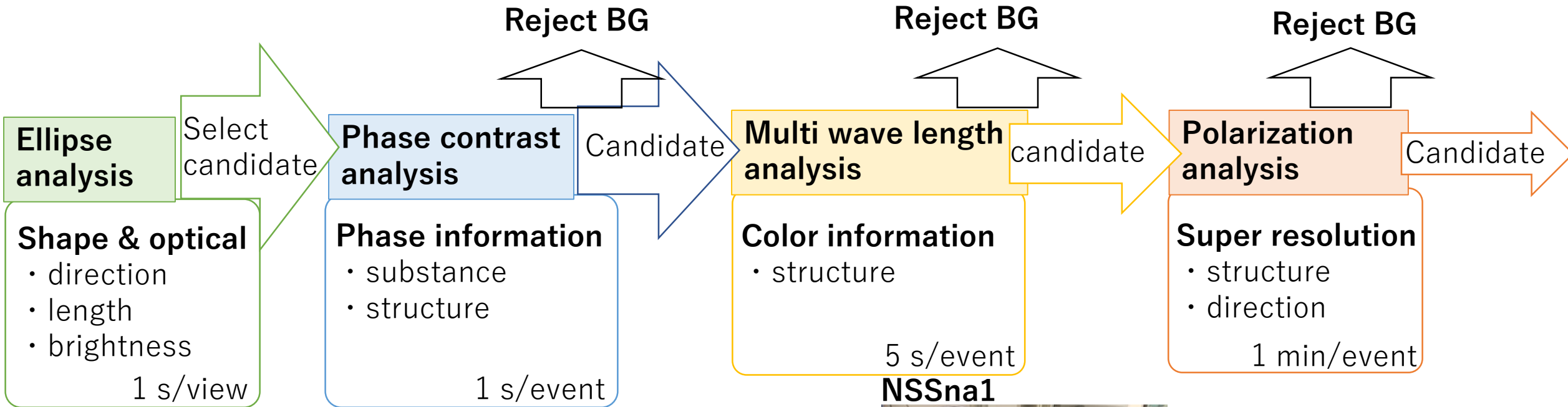


Possible to readout information beyond Rayleigh's limit.

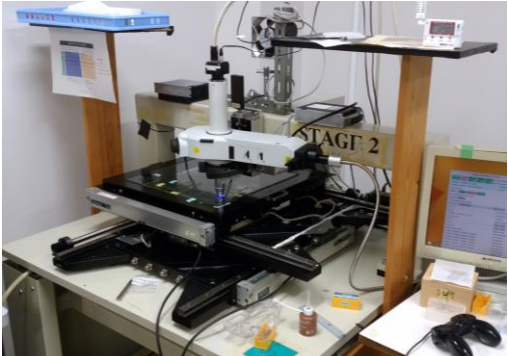
Analysis chain in NEWSdm

Full Volume scanning

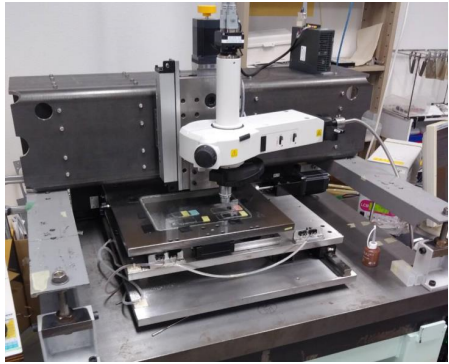
Detail Event analysis
(point scanning)



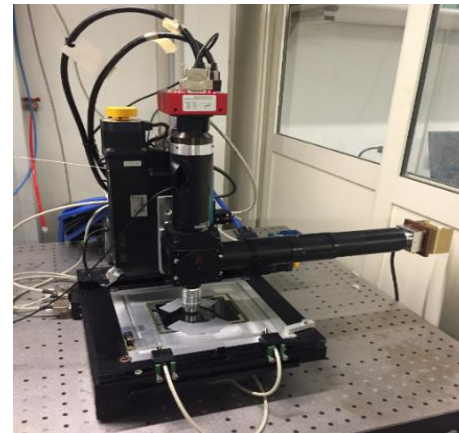
PTS2



PTS3



NSSna1



Future plan toward 10 kg scale experiment

First Goal :

search DAMA region

-> at least need to 10 kg · year NIT explore

put it into practice



need 10kg/y scanning speed

Time schedule of increasing 1st Scanning speed (kg/year/system)

2019 July

**0.026 kg/y/
× 2 systems**

2020 Apr

**0.166 kg/y
× 3 systems**

2021 Apr

**1.06 kg/y
× More than 3 systems**

After achieving 1kg/year/system

1kg/year/ system × 10 system
-> total scanning speed 10 kg/year

Shorten scanning time

Goal : 1.25 -> 0.2 s/view

- **High speed camera**
(300 fps -> 1000 fps)
- **Increase stage speed**

Expand scan volume

Goal : expand 6.4 times

- **high pixel camera or add camera**
(2M -> 4 M pixel)
- **use low magnification lens**
(x100 -> x60; with image complement)

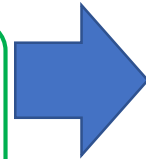
Summary

Readout nanoscale information

Use multiple analysis -> get super resolution information

Full volume scanning

- ellipse fitting



Detail event analysis

- Polarization
- multi wavelength
- phase contrast



Combine all information by machine learning

- reconstruct Nano scale information
- reject BG events

full volume scanning speed

Recently velocity : 26.5 g/year -> limit experimental scale

Toward 10 kg scanning

Goal : 26.5 g/year/machine -> 1kg/year/machine

- Shorten scanning time : 1.25 -> 0.2 s/view
- Expand scanning volume : 6.4 times



Finally 10 scanning machine use for analysis

1kg/year/machine * 10 = 10 kg /year